

## BETA DECAY OF $^{56}\text{Cu}$ TO EXCITED STATES OF $^{56}\text{Ni}$

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Nuclei having  $N$  close to  $Z$  serve as a perfect laboratory for the study of nuclear properties dependent on residual proton-neutron interactions, since these interactions are expected to have their maximum when  $N = Z$ . We have completed a study of the  $^{56}\text{Cu}$   $\beta$ -decay to excited states of  $^{56}\text{Ni}$  in order to measure the half-life and decay properties of this  $T_z = -1$  nucleus.

A  $^{58}\text{Ni}^{15+}$  beam was extracted from the superconducting ECR source and accelerated to 70 MeV/nucleon using the K1200 cyclotron. The maximum beam intensity of  $^{58}\text{Ni}$  measured before the A1200 production target was 1.6 pA. The beam was made incident on a 202 mg/cm<sup>2</sup> Be target at the entrance of A1200 fragment separator. The momentum acceptance of A1200 was set to 3% using a slit at the first dispersive image. An Al wedge at the second dispersive image was used to separate the nuclei of interests from other fragmentation products. Further  $M/q$  separation was achieved using the Reaction Product Mass Separator (RPMS). Fragments were identified using their energy loss in a 300  $\mu\text{m}$  Si PIN detector and the fragment time-of-flight measured between the K1200 cyclotron radiofrequency and Si PIN detector. An implantation detector telescope consisting of three Si detectors with thickness of 300, 150, and 1000  $\mu\text{m}$ , respectively, was placed at RPMS tail. The implantation point was viewed by two Ge-detectors with relative efficiencies of 80% and 120% and a cylindrical  $\beta$  detector with a geometrical efficiency 80% of  $4\pi$ .

The RPMS was tuned using stronger secondary beams of  $^{55}\text{Ni}$  and  $^{54}\text{Co}$ . After this, the magnetic field value of RPMS was tuned to be optimum at  $^{56}\text{Cu}$ . Due to low count rates and scattered beam, the identification of  $^{56}\text{Cu}$  was difficult. Clear evidence of the beta decay of  $^{56}\text{Cu}$  to excited states of  $^{56}\text{Ni}$  was seen with continuous beam implantation. The total collection time during this continuous beam was 4 1/2 hours and the resulting gamma spectrum is shown in Figure 1. A preliminary beta half-life has been determined by using the ratios of the growth-in ( $I_1$ ) and decay period ( $I_2$ ). If  $X$  is the length of the in-growth period and  $Y$  is the length of the decay period then the number of the observed decay events at in-growth and decay periods can be written as [1]:

$$I_1 = \int_0^X N(1 - \exp(-\lambda t)) dt = NX + \frac{N}{\lambda}(\exp(-\lambda X) - 1)$$

$$I_2 = \int_0^Y N_0 \exp(-\lambda t) dt = \frac{N}{\lambda}(\exp(-\lambda X) - 1)(\exp(-\lambda Y) - 1)$$

The ratio between integrals is

$$\frac{I_1}{I_2} = \frac{\lambda X + \exp(-\lambda X) - 1}{(\exp(-\lambda X) - 1)(\exp(-\lambda Y) - 1)}$$

Using this information the value of  $\lambda$  can be obtained from the above equations by iteration. The data used for the in-growth period was the continuous beam implantation data (saturated source) and the data used for the decay period included all runs collected using a 100 ms beam off time. The total collection time during the decay period runs was 10 hours. Using the counts in the  $^{56}\text{Ni}$   $\gamma$ -peaks with energies of 1223, 2700, and 3700 keV, we extract a preliminary half-life of 0.2 +0.3/-0.1 s.

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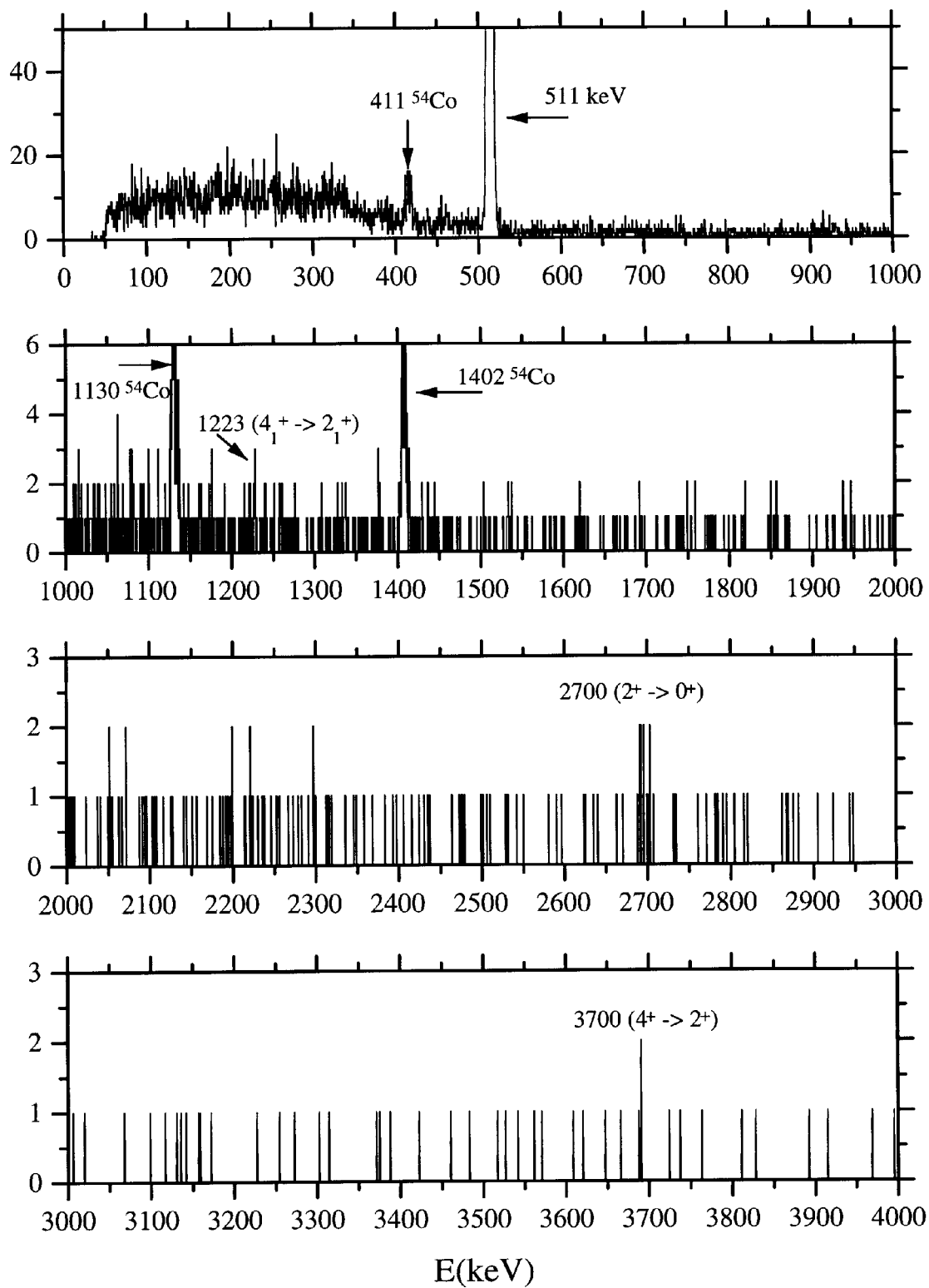


Figure 1. Partial gamma-ray spectrum showing transitions observed following the beta decay of  $^{56}\text{Cu}$ .

#### References

1. A. Jokinen, Ph.D. thesis, Research Report 3/1994, Dept. of Physics, University of Jyväskylä.